

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/647,242	<b>Applicant(s)/Patent under Reexamination</b> TAKEHIRO HASEGWAA
	<b>Examiner</b> Son L. Mai	<b>Art Unit</b> 2827

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
above searched		04/22/05	fh